

SBVS139B-JANUARY 2010-REVISED JANUARY 2011

TLC59281

# 16-Channel, Constant-Current LED Driver

Check for Samples: TLC59281

## **FEATURES**

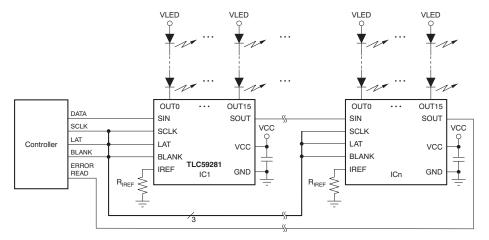
- 16 Channels, Constant-Current Sink Output with On/Off Control
- 35-mA Capability (Constant-Current Sink)
- **10-ns High-Speed Constant-Current Switching Transient Time**
- Low On-Time Error
- LED Power-Supply Voltage up to 17 V
- $V_{CC} = 3.0 V \text{ to } 5.5 V$
- **Constant-Current Accuracy:** 
  - Channel-to-Channel =  $\pm 1\%$
  - Device-to-Device = ±1%
- **CMOS Logic Level I/O**
- 35-MHz Data Transfer Rate
- 20-ns BLANK Pulse Width
- Operating Temperature: -40°C to +85°C

## **APPLICATIONS**

- **LED Video Displays**
- **Message Boards**
- Illumination

## DESCRIPTION

The TLC59281 is a 16-channel, constant-current sink LED driver. Each channel can be turned on/off by writing serial data to an internal register. The constant-current value of all 16 channels is set by a single external resistor.



Typical Application Circuit (Multiple Daisy-Chained TLC59281s)



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PRODUCT	PACKAGE-LEAD	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY						
TI 050004		TLC59281DBQR	Tape and Reel, 2500						
TLC59281	SSOP-24/QSOP-24	TLC59281DBQ	Tube, 50						
TI 050004		TLC59281RGER	Tape and Reel, 3000						
TLC59281	QFN-24	TLC59281RGE	Tape and Reel, 250						

### PACKAGE/ORDERING INFORMATION<sup>(1)</sup>

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.

## ABSOLUTE MAXIMUM RATINGS<sup>(1)(2)</sup>

Over operating free-air temperature range, unless otherwise noted.

	PARA	METER	TLC59281	UNIT
V <sub>CC</sub>	Supply voltage: V <sub>CC</sub>		-0.3 to +6.0	V
I <sub>OUT</sub>	Output current (dc)	OUT0 to OUT15	40	mA
V <sub>IN</sub>	Input voltage range	SIN, SCLK, LAT, BLANK, IREF	–0.3 to V <sub>CC</sub> + 0.3	V
V		SOUT	–0.3 to V <sub>CC</sub> + 0.3	V
V <sub>OUT</sub>	Output voltage range	OUT0 to OUT15	-0.3 to +18	V
T <sub>J(MAX)</sub>	Operating junction temperature		+150	°C
T <sub>STG</sub>	Storage temperature range		-55 to +150	°C
		Human body model (HBM)	2	kV
	ESD rating	Charged device model (CDM)	500	V

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

(2) All voltage values are with respect to network ground terminal.

### **DISSIPATION RATINGS**

PACKAGE	OPERATING FACTOR ABOVE $T_A = +25^{\circ}C$	T <sub>A</sub> < +25°C POWER RATING	T <sub>A</sub> = +70°C POWER RATING	T <sub>A</sub> = +85°C POWER RATING	
SSOP-24/QSOP-24	14.3 mW/°C	1782 mW	1140 mW	927 mW	
QFN-24 <sup>(1)</sup>	24.8 mW/°C	3106 mW	1988 mW	1615 mW	

(1) The package thermal impedance is calculated in accordance with JESD51-5.



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## **RECOMMENDED OPERATING CONDITIONS**

At  $T_A = -40^{\circ}$ C to +85°C, unless otherwise noted.

			Т	LC59281		
	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
DC Charact	eristics: V <sub>CC</sub> = 3 V to 5.5 V		•			
V <sub>CC</sub>	Supply voltage		3.0		5.5	V
Vo	Voltage applied to output	OUT0 to OUT15			17	V
V <sub>IH</sub>	High-level input voltage		$0.7 \times V_{CC}$		V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level input voltage		GND		0.3 × V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	SOUT			-1	mA
I <sub>OL</sub>	Low-level output current	SOUT			1	mA
I <sub>OLC</sub>	Constant output sink current	OUT0 to OUT15	2		35	mA
T <sub>A</sub>	Operating free-air temperature range		-40		+85	°C
TJ	Operating junction temperature range		-40		+125	°C
AC Charact	eristics: V <sub>CC</sub> = 3 V to 5.5 V					
f <sub>CLK</sub> (SCLK)	Data shift clock frequency	SCLK			35	MHz
T <sub>WH0</sub>		SCLK	10			ns
T <sub>WL0</sub>		SCLK	10			ns
T <sub>WH1</sub>	Pulse duration	LAT	20			ns
T <sub>WH2</sub>		BLANK	20			ns
T <sub>WL2</sub>		BLANK	20			ns
T <sub>SU0</sub>	Catura time	SIN–SCLK↑	4			ns
T <sub>SU1</sub>	Setup time	LAT↑–SCLK↑	100			ns
T <sub>H0</sub>	Lold time	SIN–SCLK↑	3			ns
T <sub>H1</sub>	Hold time	LAT↑–SCLK↑	10			ns



## **ELECTRICAL CHARACTERISTICS**

At  $V_{CC}$  = 3.0 V to 5.5 V and  $T_A$  = -40°C to +85°C. Typical values at  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.

			т	LC59281		
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -1 mA at SOUT	$V_{CC} - 0.4$		V <sub>CC</sub>	V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1 mA at SOUT	0		0.4	V
I <sub>IN</sub>	Input current	$V_{\text{IN}}$ = $V_{\text{CC}}$ or GND at SIN, SCLK, LAT, and BLANK	-1		1	μA
I <sub>CC1</sub>		SIN/SCLK/LAT = low, BLANK = high, V_{OUTn} = 1 V, R_{IREF} = 27 k\Omega		1	2	mA
I <sub>CC2</sub>		SIN/SCLK/LAT = low, BLANK = high, V <sub>OUTn</sub> = 1 V, R <sub>IREF</sub> = 3 k $\Omega$		4.5	8	mA
I <sub>CC3</sub>	Supply current (V <sub>CC</sub> )	$\label{eq:sinverse} \begin{split} \text{SIN/SCLK/LAT/BLANK} &= \text{Iow, V}_{\text{OUTn}} = 1 \ \text{V}, \\ \text{R}_{\text{IREF}} = 3 \ \text{k}\Omega \end{split}$		7	18	mA
I <sub>CC4</sub>		$\label{eq:sinverse} \begin{split} & \text{SIN/SCLK/LAT/BLANK} = \text{Iow, } V_{\text{OUTn}} = 1 \text{ V,} \\ & \text{R}_{\text{IREF}} = 1.5 \text{ k}\Omega \end{split}$		16	40	mA
I <sub>OLC</sub>	Constant output current	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ (see Figure 6), at OUT0 to OUT15	31	34	37	mA
I <sub>OLKG</sub>	Output leakage current	All OUTn for constant-current driver, all outputs off BLANK = high, $V_{OUTn} = V_{OUTfix} = 17$ V, $R_{IREF} = 1.5$ k $\Omega$ (see Figure 6), at OUT0 to OUT15			0.1	μΑ
ΔI <sub>OLC</sub>	Constant-current error (channel-to-channel) <sup>(1)</sup>	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15		±1	±3	%
∆I <sub>OLC1</sub>	Constant-current error (device-to-device) <sup>(2)</sup>	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15		±1	±6	%
∆l <sub>OLC2</sub>	Line regulation <sup>(3)</sup>	All OUTn = ON, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$ at OUT0 to OUT15		±0.5	±1	%/V
∆I <sub>OLC3</sub>	Load regulation <sup>(4)</sup>	All OUTn = ON, $V_{OUTn}$ = 1 V to 3V, $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega,$ at OUT0 to OUT15		±1	±3	%/V
V <sub>IREF</sub>	Reference voltage output	R <sub>IREF</sub> = 1.5 kΩ	1.16	1.20	1.24	V

(1) The deviation of each output from the average of OUT0–OUT15 constant-current. Deviation is calculated by the formula:

 $\Delta (\%) = \frac{I_0}{(I_{OUT0} + I_{OUT1} + ...)}$ 

$$\frac{I_{OUTn}}{I_{0} \dots + I_{OUT14} + I_{OUT15}} - 1 \times 100$$

(2) The deviation of the OUT0–OUT15 constant-current average from the ideal constant-current value. Deviation is calculated by the following formula:

$$\Delta (\%) = \left( \begin{array}{c} (I_{OUT0} + I_{OUT1} + \dots + I_{OUT14} + I_{OUT15}) \\ \hline 16 \\ \hline 16 \\ \hline 10 \\ \hline$$

Ideal current is calculated by the formula:  $\begin{bmatrix} 1 & 20 \end{bmatrix}$ 

$$I_{OUT(IDEAL)} = 42 \times \left( \frac{1.20}{R_{IREF}} \right)$$

- (3) Line regulation is calculated by this equation:  $\Delta (\%/V) = \left( \frac{(I_{\text{OUTn}} \text{ at } V_{\text{CC}} = 5.5 \text{ V}) - (I_{\text{OUTn}} \text{ at } V_{\text{CC}} = 3.0 \text{ V})}{(I_{\text{OUTn}} \text{ at } V_{\text{CC}} = 3.0 \text{ V})} \right) \times \frac{100}{5.5 \text{ V} - 3 \text{ V}}$
- (4) Load regulation is calculated by the equation:  $\Delta (\%/V) = \left( \frac{(I_{OUTn} \text{ at } V_{OUTn} = 3 \text{ V}) - (I_{OUTn} \text{ at } V_{OUTn} = 1 \text{ V})}{(I_{OUTn} \text{ at } V_{OUTn} = 1 \text{ V})} \right) \times \frac{100}{3 \text{ V} - 1 \text{ V}}$

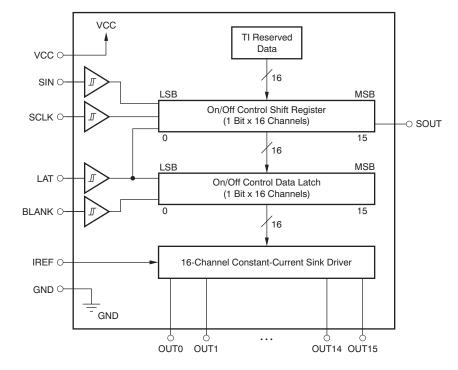


### SWITCHING CHARACTERISTICS

At  $V_{CC}$  = 3.0 V to 5.5 V,  $T_A$  = -40°C to +85°C,  $C_L$  = 15 pF,  $R_L$  = 130  $\Omega$ ,  $R_{IREF}$  = 1.5 k $\Omega$ , and  $V_{LED}$  = 5.5 V. Typical values at  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.

			TL	C59281		
	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
t <sub>R0</sub>	Diag time	SOUT (see Figure 5)		5	15	ns
t <sub>R1</sub>	Rise time	OUTn (see Figure 4)		10	30	ns
t <sub>F0</sub>	- Fall time	SOUT (see Figure 5)		5	15	ns
t <sub>F1</sub>	Fail time	OUTn (see Figure 4)		10	30	ns
t <sub>D0</sub>		SCLK↑ to SOUT		8	20	ns
t <sub>D1</sub>	Propagation delay time	LAT↑ or BLANK↓ to OUTn sink current on (see Figure 10)		12	30	ns
t <sub>D2</sub>		LAT↑ or BLANK↑ to OUTn sink current off (see Figure 10)		12	30	ns
t <sub>ON_ERR</sub>	Output on-time error <sup>(1)</sup>	On/off latch data = all '1', 20 ns BLANK low level one-shot pulse input (see Figure 4)	-8		+8	ns

(1) Output on-time error ( $t_{ON\_ERR}$ ) is calculated by the formula:  $t_{ON\_ERR}$  (ns) =  $t_{OUT\_ON}$  – BLANK low level one-shot pulse width ( $T_{WL2}$ ).  $t_{OUT\_ON}$  indicates the actual on-time of the constant-current driver.



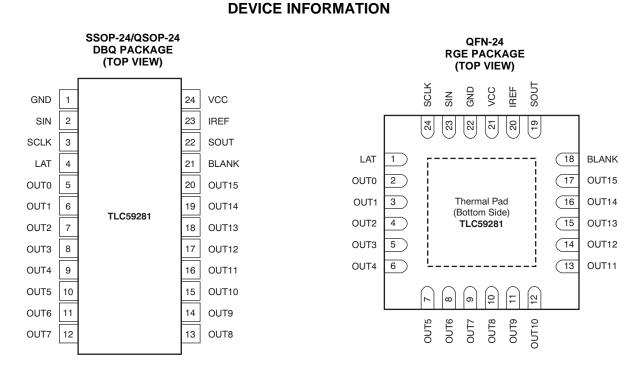
## FUNCTIONAL BLOCK DIAGRAM

# TLC59281



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NOTE: Thermal pad is not connected to GND internally. The thermal pad must be connected to GND via the PCB pattern.

TEXAS INSTRUMENTS

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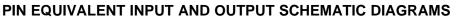
### **TERMINAL FUNCTIONS**

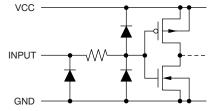
TERMINAL				
NAME	DBQ	RGE	I/O	DESCRIPTION
SIN	2	23	I	Serial data input for driver on/off control. When SIN = high level, data '1' are written into LSB of the on/off control shift register at the rising edge of SCLK.
SCLK	3	24	I	Serial data shift clock. Schmitt buffer input. All data in the on/off control shift register are shifted toward the MSB by 1-bit synchronization of SCLK. A rising edge on SCLK is allowed 100 ns after a rising edge of LAT.
LAT	4	1	I	Edge triggered latch. The data in the on/off control data shift register are transferred to the on/off control data latch at this rising edge. At the same time, the data in the on/off control shift register are replaced with TI reserved data for production test. LAT must be toggled only once after the shift data are updated to avoid the on/off control latch data being replaced with TI reserved data in the shift register. The reserved data is not a fixed number.
BLANK	21	18	I	Blank, all outputs. When BLANK = high level, all constant-current outputs (OUT0–OUT15) are forced off. When BLANK = low level, all constant-current outputs are controlled by the on/off control data in the data latch.
IREF	23	20	I/O	Constant-current value setting, OUT0–OUT15 sink constant-current is set to desired value by connection to an external resistor between IREF and GND.
SOUT	22	19	0	Serial data output. This output is connected to the MSB of the on/off data shift register. SOUT data changes at the rising edge of SCLK.
OUT0	5	2	0	Constant-current output. Each output can be tied together with others to increase the constant-current. Different voltages can be applied to each output.
OUT1	6	3	0	Constant-current output
OUT2	7	4	0	Constant-current output
OUT3	8	5	0	Constant-current output
OUT4	9	6	0	Constant-current output
OUT5	10	7	0	Constant-current output
OUT6	11	8	0	Constant-current output
OUT7	12	9	0	Constant-current output
OUT8	13	10	0	Constant-current output
OUT9	14	11	0	Constant-current output
OUT10	15	12	0	Constant-current output
OUT11	16	13	0	Constant-current output
OUT12	17	14	0	Constant-current output
OUT13	18	15	0	Constant-current output
OUT14	19	16	0	Constant-current output
OUT15	20	17	0	Constant-current output
VCC	24	21	_	Power-supply voltage
GND	1	22	—	Power ground

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## PARAMETER MEASUREMENT INFORMATION





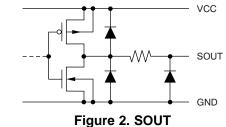
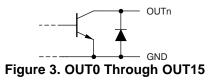
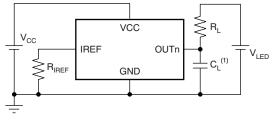


Figure 1. SIN, SCLK, LAT, BLANK

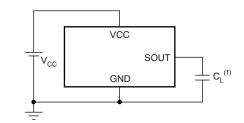


## **TEST CIRCUITS**



(1)  $C_L$  includes measurement probe and jig capacitance.





(1)  $C_L$  includes measurement probe and jig capacitance.

Figure 5. Rise Time and Fall Time Test Circuit for SOUT

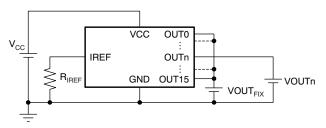


Figure 6. Constant-Current Test Circuit for OUTn

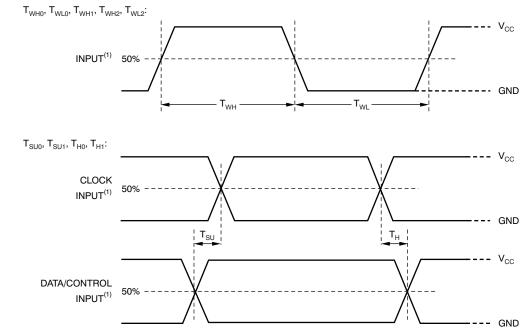


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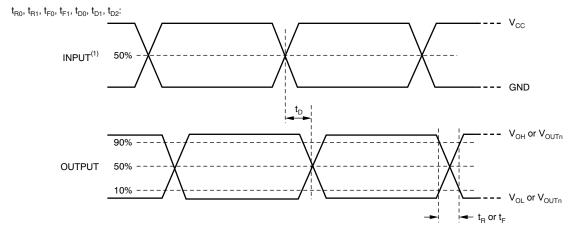
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### **TIMING DIAGRAMS**



(1) Input pulse rise and fall time is 1 ns to 3 ns.

Figure 7. Input Timing



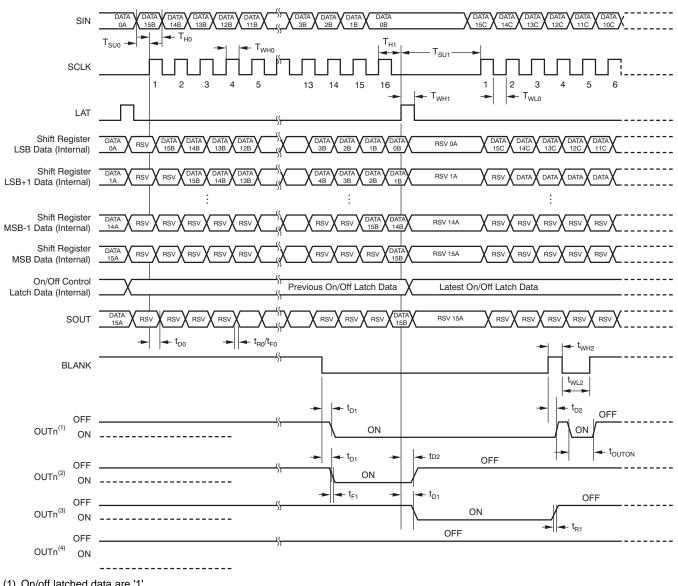
(1) Input pulse rise and fall time is 1 ns to 3 ns.



EXAS **ISTRUMENTS** 

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(1) On/off latched data are '1'.

(2) On/off latched data are changed from '1' to '0' at the second LAT signal.

(3) On/off latched data are changed from '0' to '1' at the second LAT signal.

(4) On/off latched data are '0'.

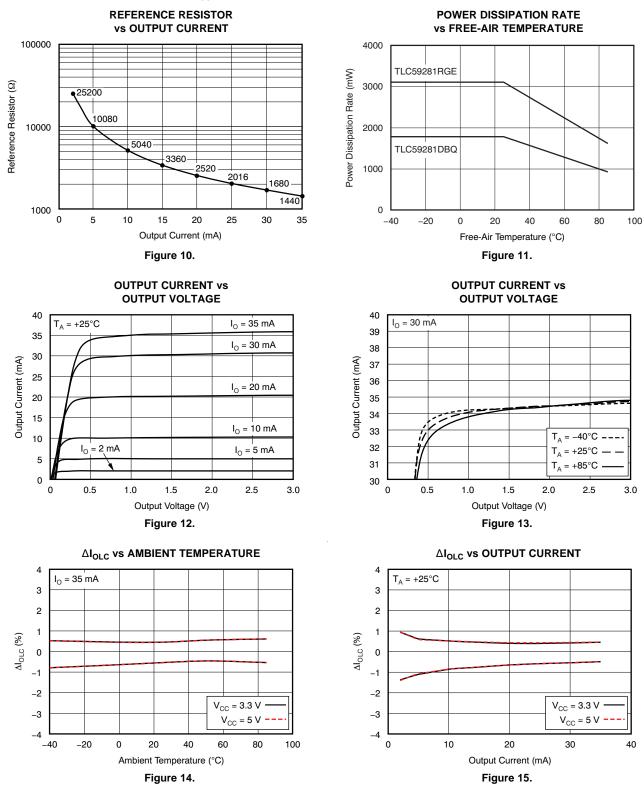




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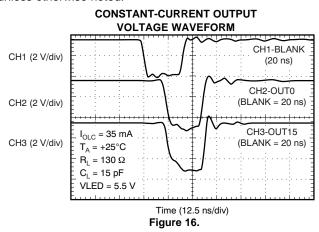
## **TYPICAL CHARACTERISTICS**

At  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.



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## **TYPICAL CHARACTERISTICS (continued)**

At  $V_{CC}$  = 3.3 V and  $T_A$  = +25°C, unless otherwise noted.



## DETAILED DESCRIPTION

### SETTING FOR THE CONSTANT SINK CURRENT VALUE

The constant-current values are determined by an external resistor ( $R_{IREF}$ ) placed between IREF and GND. The resistor ( $R_{IREF}$ ) value is calculated by Equation 1.

$$R_{IREF} (k\Omega) = \frac{V_{IREF} (V)}{I_{OLC} (mA)} \times 42$$

Where:

 $V_{IREF}$  = the internal reference voltage on the IREF pin (typically 1.20 V)

(1)

 $I_{OLC}$  must be set in the range of 2 mA to 35 mA. The constant sink current characteristic for the external resistor value is shown in Figure 10. Table 1 describes the constant-current output versus external resistor value.

Table 1. Constant-Current Out	put versus External Resistor Value

I <sub>OLCMax</sub> (mA, Typical)	<b>R<sub>IREF</sub> (k</b> Ω)
35	1.44
30	1.68
25	2.02
20	2.52
15	3.36
10	5.04
5	10.1
2	25.2

## **CONSTANT-CURRENT DRIVER ON/OFF CONTROL**

When BLANK is low, the corresponding output is turned on if the data in the on/off control data latch are '1' and remains off if the data are '0'. When BLANK is high, all outputs are forced off. This control is shown in Table 2.

#### Table 2. On/Off Control Data Truth Table

ON/OFF CONTROL LATCH DATA	CONSTANT-CURRENT OUTPUT STATUS
0	Off
1	On

When the IC is initially powered on, the data in the on/off control shift register and data latch are not set to the respective default value. Therefore, the on/off control data must be written to the data latch before turning the constant-current output on. BLANK should be at a high level when powered on because the constant-current may be turned on as a result of random data in the on/off control latch.

The on/off data corresponding to any unconnected OUTn outputs should be set to '0' before turning on the remaining outputs. Otherwise, the supply current ( $I_{CC}$ ) increases while the LEDs are on.

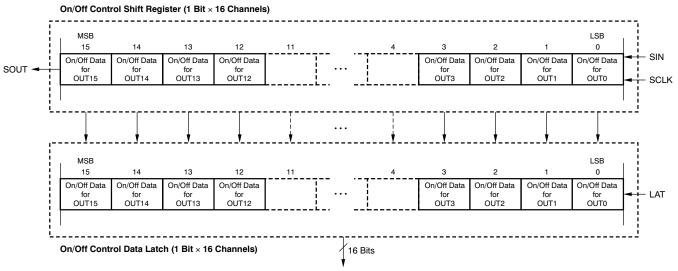


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### **REGISTER CONFIGURATION**

The TLC59281 has an on/off control data shift register and data latch. Both the on/off control shift register and latch are 16 bits long and are used to turn the constant-current drivers on and off. Figure 17 shows the shift register and latch configuration. The data at the SIN pin are shifted in to the LSB of the shift register at the rising edge of the SCLK pin; SOUT data change at the rising edge of SCLK. The timing diagram for data writing is shown in Figure 18. The driver on/off is controlled by the data in the on/off control data latch.

The on/off data are latched into the data latch by a rising edge of LAT after the data are written into the on/off control shift register by SIN and SCLK. At the same time, the data in the on/off control shift register are replaced with TI reserved data for production test. Therefore, LAT must be input only once after the on/off data update to avoid the on/off control data latch being replaced with TI reserved data in the shift register. When the IC initially powers on, the data in the on/off control shift register and latch are not set to the default values; on/off control data must be written to the on/off control data latch before turning the constant-current output on. BLANK should be high when the IC is powered on because the constant-current may be turned on at that time as a result of random values in the on/off data latch. All constant-current outputs are forced off when BLANK is high.



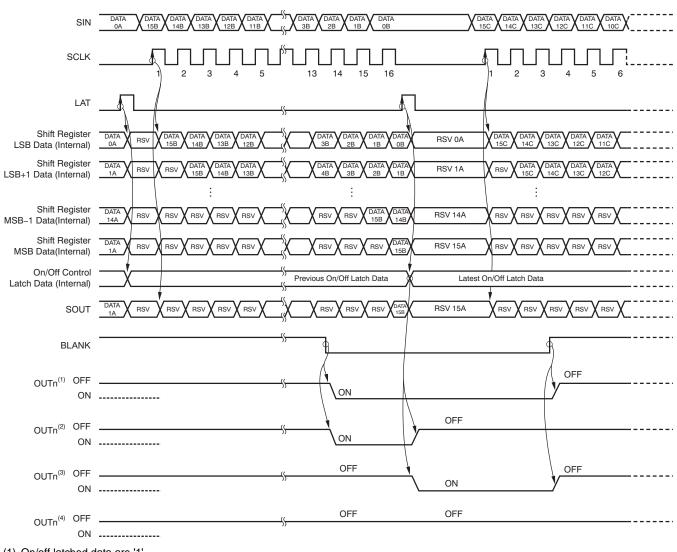
To Constant Current Driver Control Block

Figure 17. On/Off Control Shift Register and Latch Configuration





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(1) On/off latched data are '1'.

(2) On/off latched data are changed from '1' to '0' at the second LAT signal.

(3) On/off latched data are changed from '0' to '1' at the second LAT signal.

(4) On/off latched data are '0'.

### Figure 18. On/Off Control Operation

### LAYOUT CONSIDERATIONS

The output current transient time in the TLC59281 is very fast. In addition, all outputs turn on or off at the same time to minimize the output on-time error. This high current demand can cause GND to shift in the entire system, and lead to false triggering of signals. To overcome this issue, design all GND lines to be as wide and short as possible in order to reduce parasitic inductance and resistance.



## **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	changes from Revision A (September 2010) to Revision B	Page
•	Added Layout Considerations section	15
CI	changes from Original (January 2010) to Revision A	Page
•	Changed SO-24 to SSOP-24/QSOP-24 in Package/Ordering Information table	2
•	Changed SO-24 to SSOP-24/QSOP-24 in Dissipation Ratings table	2
•	Changed SO-24 to SSOP-24/QSOP-24 in DBQ pinout	6



15-Apr-2017

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLC59281DBQ	ACTIVE	SSOP	DBQ	24	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC59281	Samples
TLC59281DBQR	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC59281	Samples
TLC59281RGER	ACTIVE	VQFN	RGE	24	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TLC 59281	Samples
TLC59281RGET	ACTIVE	VQFN	RGE	24	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR		TLC 59281	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



15-Apr-2017

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC59281RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
TLC59281RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

26-Mar-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC59281RGER	VQFN	RGE	24	3000	367.0	367.0	35.0
TLC59281RGET	VQFN	RGE	24	250	210.0	185.0	35.0

# **GENERIC PACKAGE VIEW**

# VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

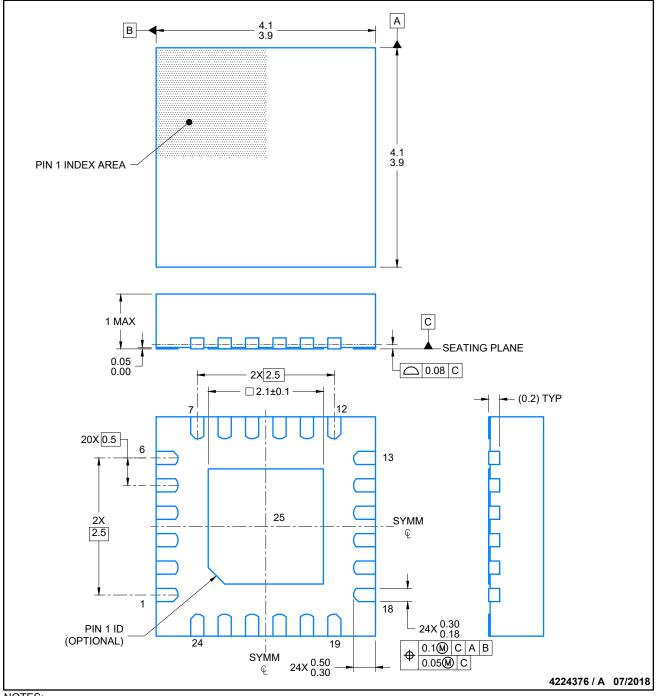


# **RGE0024C**

# **PACKAGE OUTLINE**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

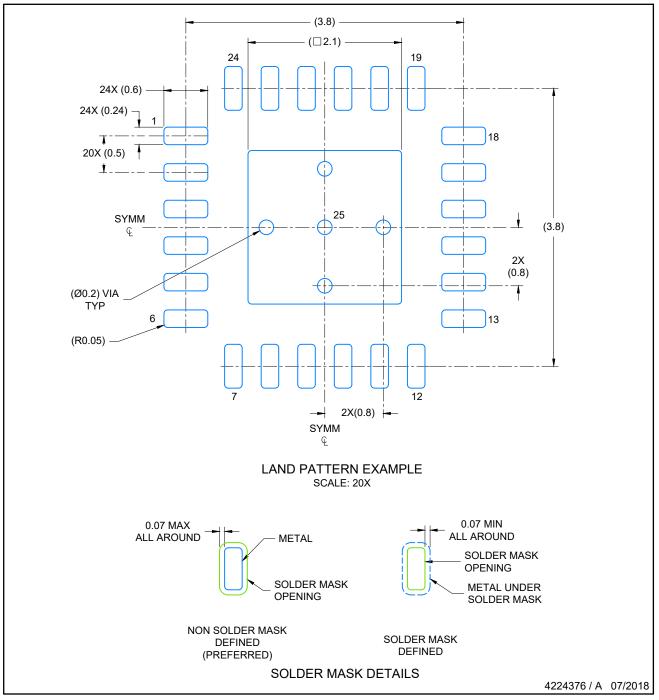


# **RGE0024C**

# **EXAMPLE BOARD LAYOUT**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

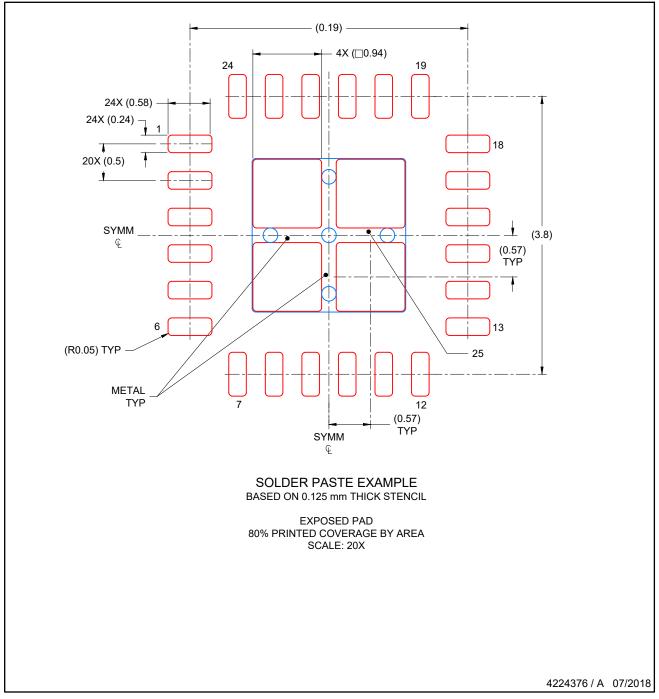


# **RGE0024C**

# **EXAMPLE STENCIL DESIGN**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..



DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AE.



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